

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Application Number 10/775,702

Filing Date February 9, 2004

First Named Inventor Ikuya Yagisawa

Art Unit 2187

Examiner Name Matthew A. Bradley

Attorney Docket Number 16869N-104800US

(use as many sheets as necessary)

Sheet 1 of 2

U.S. PATENT DOCUMENTS+ Document Number Name of Patentee or Applicant of Cited Document Publication Date MM-DD-YYYY Pages, Columns, Lines, Where Examiner Relevant Passages or Relevant Number Kind Code² (if known) Initials Figures Appear 2005/0060618 03-17-2005 Guba MB 2004/0260987 12-23-2004 Guha et al. MB 2 3 2004/0190183 09-30-2004 Tamai et al. $\mathcal{M}^{\mathcal{L}}$ 4 6,799,283 09-28-2004 Tamai et al. 5 2004/0160975 08-19-2004 Frank et al. 6 6,598,174 07-22-2003 Parks et al. 2003/0120863 06-26-2003 Lee et al. 2003/0120864 06-26-2003 Lee et al. 8 2003/0120869 06-26-2003 Lee et al. 8 2003/0101316 Krishnamurthy 10 05-29-2003 05-30-2002 Lerman et al. 11 2002/0066050 12 6,154,853 11-28-2000 Kedem 13 6,044,444 03-28-2000 Ofek 10-26-1999 Jeffries et al. 14 5,974,544 09-28-1999 Styczinski 15 m 5,959,860 09-01-1998 Chen et al. 16 WE 5,802,264 11-30-1993 Lavallee et al. 17 5,267,242 WB 07-16-1990 Galbraith et al. MP 18 5,537,567

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Examiner Signature	Matthew	Bradley	Date Considered	l	19/06	
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Substitute for form 1449B/PTO				Complete if Known			
INIEO	INFORMATION DISCLOSUR		CI OCUDE	Application Number	10/775,702		
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			•	Art Unit	2187		
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Sheet	2	of	2	Attorney Docket Number	16869N-104800US		

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials *	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T 2
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	Examiner Signature	Motthew	Bradley	Date Considered	1	9	106	
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PTO/SB/08A (08-03) titute for form 1449A/PTO Complete if Known 10/775,702 **Application Number INFORMATION DISCLOSURE** Filing Date February 9, 2004 STATEMENT BY APPLICANT First Named Inventor Ikuya YAGISAWA Art Unit 2187 (use as many sheets as necessary) **Examiner Name** M. Bradley of 16869N-104800US Sheet **Attorney Docket Number**

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Examiner Initials*	Cite No.1	Number Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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